

# **Enhancement Mode N+P-Channel Power MOSFET**

 $SOP8/N+PMOS/40V/\pm20V/1.5V/5A/45m\Omega$ 

 $-40V/\pm 20V/-1.55V/-5A/60m\Omega$ 

Rev<sub>0.5</sub>





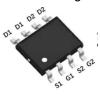
# 40V N+P-Channel MOSFET

#### 1.Features

- High power and current handing capability
- ◆ Lead free product is acquired
- Fast switching
- ◆ Surface mount package

## 2.Applications

- Power Switching Application
- ◆ Load Switching



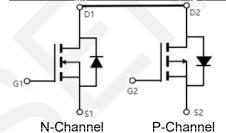
SOP8
Pin Description

## ♦ N-Channel

V <sub>DS</sub>	R <sub>DS(on)</sub> Typ.	I <sub>D</sub>
40V	45mΩ @ 10V	44
	59mΩ @ 4.5V	4A

## ◆ P-Channel

V <sub>DS</sub>	R <sub>DS(on)</sub> Typ.	l <sub>D</sub>
-40V	60mΩ @ -10V	<b>Γ</b> Λ
	75mΩ @ -4.5V	-5A



Schematic Diagram

## 3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP4614F	LKS0406	SOP8	4,000	48,000

## 4.Absolute Max Ratings at Ta=25°C (Note1)

Paramete	Symbol	N-chanel	P-chanel	Units	
Drain to Source Voltage		V <sub>DSS</sub>	40	-40	V
Gate to Source Voltage		V <sub>GSS</sub>	±20 ±20		V
Drain Current (DC),	TA=25 °C	ID	5	-5	А
	TA=70 °C	ID	3	-3.5	Α
Drain Current (Pulse), PW≤300μs		I <sub>DM</sub>	20	-20	А
Total Dissipation		P <sub>D</sub>	2.0	2.0	W
Junction Temperature		Tj	150	150	°C
Storage Temperature		T <sub>stg</sub>	-55 to +150	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



# 5.Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Maximum Junction-to-Ambient	Reja	62.5	°C/W

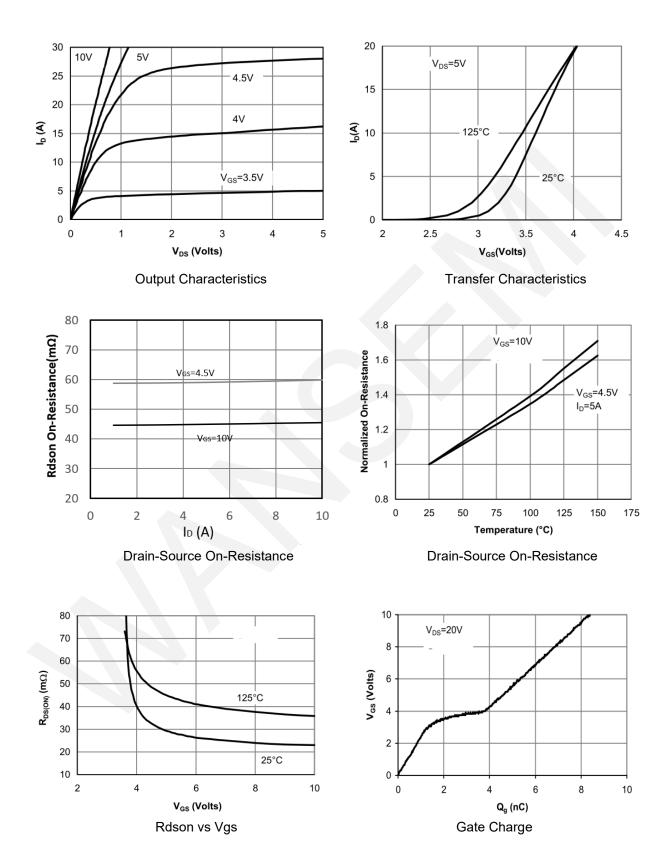
Note 2: When mounted on 1 inch square copper board  $t \le 10$ sec The value in any given application depends on the user's specific board design.

# 6.NMOS Electrical Characteristics at Ta=25°C (Note 3)

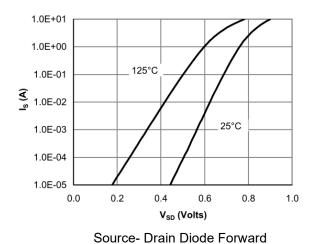
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$I_D = 250 \mu A$ , $V_{GS} = 0 V$	40		-	V
Zero-Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 40V, V <sub>GS</sub> = 0V	-		1	μΑ
Gate to Source Leakage Current	Igss	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250µA	1.0	1.5	2.5	V
Static Drain to Source On-State	Б	I <sub>D</sub> = 5A, V <sub>GS</sub> = 10V	-	45	58	mΩ
Resistance	R <sub>DS(on)</sub>	I <sub>D</sub> = 5A, V <sub>GS</sub> = 4.5V	-	59	85	mΩ
Input Capacitance	Ciss	V <sub>GS</sub> =0V,	-	404	-	pF
Output Capacitance	Coss	V <sub>DS</sub> =20V,	-	95	-	pF
Reverse Transfer Capacitance	Crss	Frequency=1.0MHz	-	37	-	pF
Turn-ON Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 20V	-	4.2	-	ns
Rise Time	tr	$V_{GS} = 10V$	-	3.3	-	ns
Turn-OFF Delay Time	t <sub>d(off)</sub>	$R_{GEN} = 2.5\Omega$	-	15.2	-	ns
Fall Time	t <sub>f</sub>	I <sub>D</sub> = 2A	-	3	-	ns
	Qg	V <sub>DS</sub> = 20V,	-	8.3	-	nC
Total Gate Charge	Qgs	V <sub>GS</sub> = 10V,	-	1.3	-	nC
	Q <sub>gd</sub>	I <sub>D</sub> = 2A	-	2.3	-	nC
Diode Forward Voltage	V <sub>FSD</sub>	I <sub>S</sub> = 5A, V <sub>GS</sub> = 0V	-	0.85	1.2	V

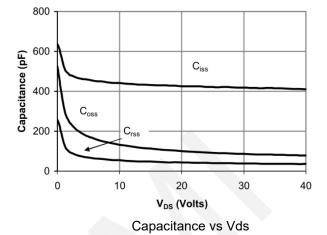


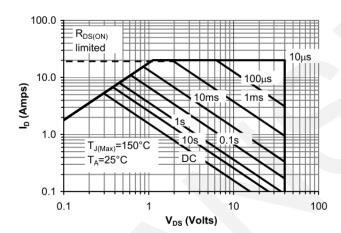
# NMOS Typical electrical and thermal characteristics



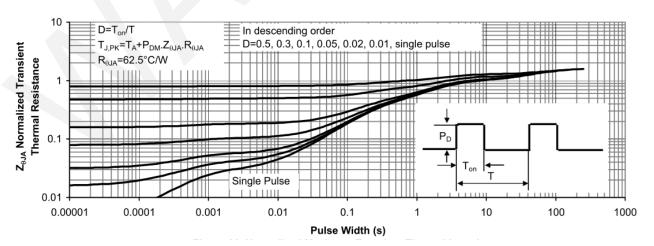








Safe Operating Area



Normalized Maximum Transient Thermal Impedance



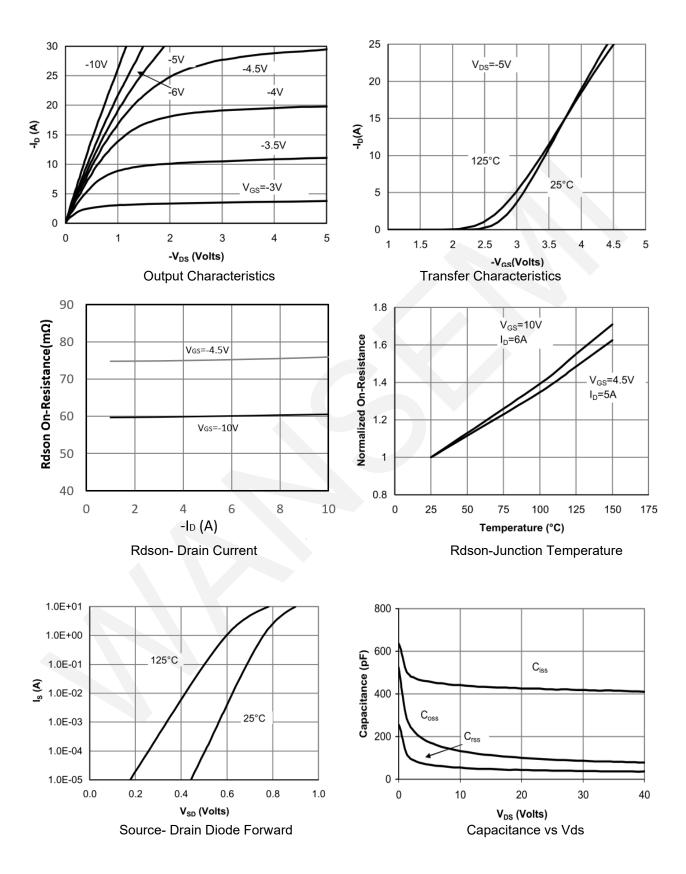
## 7.PMOS Electrical Characteristics at Ta=25°C

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$I_D = -250 \mu A, V_{GS} = 0 V$	-40		1	V
Zero-Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -40V, V <sub>GS</sub> = 0V	-	-	1	μΑ
Gate to Source Leakage Current	Igss	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =-250μA	-1.0	-1.55	-2.5	V
Static Drain to Source On-State	_	I <sub>D</sub> = -5A, V <sub>GS</sub> = -10V	-	60	75	mΩ
Resistance	R <sub>DS(on)</sub>	I <sub>D</sub> =-5A, V <sub>GS</sub> =-4.5V	-	75	105	mΩ
Input Capacitance	Ciss	V <sub>GS</sub> =0V,	-	573	-	pF
Output Capacitance	Coss	V <sub>DS</sub> =-20V,	-	53	-	pF
Reverse Transfer Capacitance	Crss	Frequency=1.0MHz	-	42	_	pF
Turn-ON Delay Time	N Delay Time $t_{d(on)}$		-	6.5	-	ns
Rise Time	t <sub>r</sub>	$V_{DD} = -20V$ $I_D = -3A$	-	14	-	ns
Turn-OFF Delay Time	t <sub>d(off)</sub>	V <sub>GS</sub> = -10V	-	34	-	ns
Fall Time	t <sub>f</sub>	$R_{GEN} = 2.5\Omega$ ,	-	18	-	ns
	Qg	V <sub>DS</sub> = -20V, V <sub>GS</sub> = -10V,	-	7.1	-	nC
Total Gate Charge	Qgs		-	1.5	-	nC
	Q <sub>gd</sub>	I <sub>D</sub> = -3A	-	1.8	-	nC
Diode Forward Voltage	V <sub>FSD</sub>	I <sub>S</sub> = -5A, V <sub>GS</sub> = 0V	-		-1.2	V

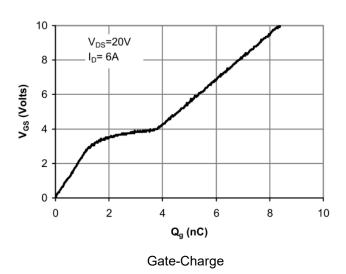
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different condit

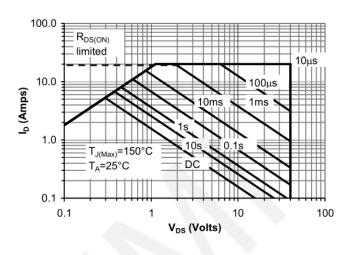


# PMOS Typical electrical and thermal characteristics

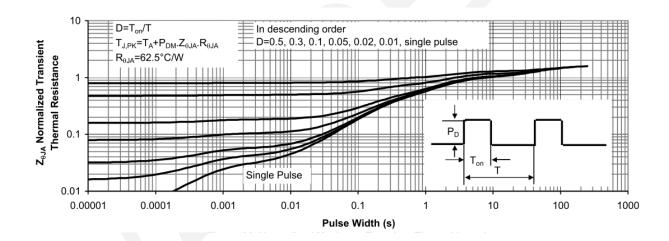








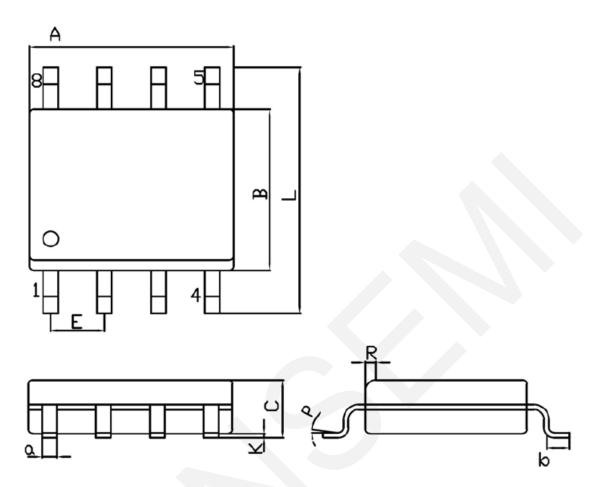
Safe Operation Area



Normalized Maximum Transient Thermal Impedance



# 8.Package Dimensions



Symbol	Dimensions In Millimeters		Symbol	Dimensions In Millimeters		
Syribox	Min	Max	Syribot	Mln	Max	
A	4.70	5,10	С	1,35	1.75	
В	3,70	4,10	۵	0,35	0.49	
L	5.80	6,20	R	0.30	0.60	
E	1.27BSC		Р	0*	7*	
K	0.12	0.22	b	0.40	1.25	



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